

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10078713	NAMIZUKA, YOSHIYUKI
Examiner		Art Unit
Dennis Rosario		2624

SEARCHED

Class	Subclass	Date	Examiner
382	199	8/18/08	DR
	311	12/11/08	DR

SEARCH NOTES

Search Notes	Date	Examiner
East,all db	8/18/08	DR
IEEE-((correct* <near/2> coefficient)<in>metadata)<and>(((edge or contour or outline) <near/5> (detect* or extract*))<in>metadata))-	8/18/08	DR
East, all db	12/11/08	DR
Google Scholar-user (coefficient or parameter or setting) mode threshold image (edge or contour or outline)-	12/11/08	DR

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner